

**Search Notes**

Application/Control No.

10/666,912

Examiner

Sing P. Chan

Applicant(s)/Patent under  
Reexamination

HAUBRICH ET AL.

Art Unit

1734

**SEARCHED**

Class	Subclass	Date	Examiner
156	344, 247, 277, 278, 584	3/28/2007	SPC
427	154-156	3/28/2007	SPC
427	272-274	3/28/2007	SPC
427	282 248.1	3/28/2007	SPC
101	114 128.21	3/28/2007	SPC
101	129	3/28/2007	SPC
118	504	3/28/2007	SPC
438	478 479 759	3/28/2007	SPC
438	763	3/28/2007	SPC
427	259 282	4/2/2007	SPC
427	258 261 265	4/3/2007	SPC

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
156	344 247 277	3/28/2007	SPC
156	278 584	3/28/2007	SPC
427	154-156	3/28/2007	SPC
427/272-274, 282, 248.1; 101/114, 128.21, 129; 118/504		3/28/2007	SPC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text and image search on EAST	3/28/2007	SPC
Inventors search on EAST and PALM on Jeanne Haubrich, Yi-Shung Chaug, Zarnag-Arh Wu, Rong-Chang Liang	3/28/2007	SPC
Conferred with Kirsten Jolley of AU 1762 in class 427 for search and classification	4/2/2007	SPC
Conferred with Frederick Parker	4/26/2007	SPC

**Search Notes (continued)**

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**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
438	759 763	3/28/2007	SPC
427	259 282	4/2/2007	SPC
427	258 261	4/30/2007	SPC
427/265		4/30/2007	SPC

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR